NOTES:

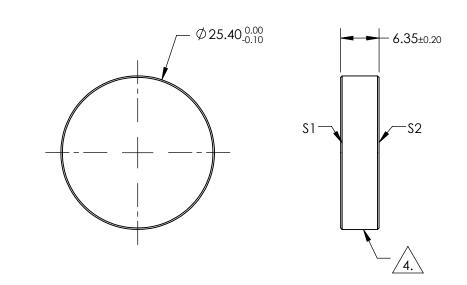
- 1. SUBSTRATE MATERIAL: FUSED SILICA
- 2. CLEAR APERTURE AND COATING APERTURE ARE CENTERED ON SURFACE
- 3. COATING (APPLY ACROSS CLEAR APERTURE) S1: R(ABS) ≥ 99.5% @ 266nm @ 45° AOI R(AVG) ≥ 99.5% @ 263-268nm @ 45° AOI

DAMAGE THRESHOLD, CW: 1 MW/cm² @ DWL PULSED: 6 J/cm² (355 nm, 20 ns, 20 Hz)

S2:NONE

4. FINE GRIND SURFACE

- 5. SURFACE FLATNESS AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. RoHS: COMPLIANT



FOR INFORMATION ONLY: DO NOT MANUFACTURE PARTS TO THIS DRAWING

	SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY					
	S1	\$2]	Edmund Optics [®]		
SHAPE	PLANO	PLANO				1165
SURFACE FLATNESS	0.1 WAVE	N/A		TITLE	Ø25.4mm, 355nm, Nd-YAG LASER LINE MIRROR (STANDARD)	
SURFACE QUALITY	10-5	N/A				
CLEAR APERTURE	Ø21.59	Ø21.59				
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	34820	SHEET 1 OF 1